Time: 2½

Total Marks: 60

N.I	B. :(1	l) All	questions are compulsory .					
	(2	2) Fig	gures to the right indicate full marks.					
	(3	(3) Draw neat diagrams wherever necessary.(4) Symbols have usual meanings unless otherwise stated.						
	(4							
	(5) Us	e of non-programmable calculator is allowed.	3,00				
				\$ 60°C				
1.	(a)	Attempt any one:						
		(i)	Describe Czochraski crystal growth method for the preparation of single	200.8				
			crystal silicon with a neat labeled diagram. Obtain the expression for)				
			doping distribution					
			as a function of the fraction solidified.					
		(ii)	Draw a labeled diagram for a conventional molecular beam epitaxy (MBE)	8				
			system and explain the growth of semiconductor with suitable example.					
	(b)	Attempt any one:						
		(i)	Describe in brief Float zone phase epitaxy technique to deposit the thin	4				
			films.					
		(ii)	Draw a labeled diagram of vapor phase epitaxy with brief explanation.	4				
2.	(a)	Attempt any one:						
		(i)	Explain diffusion process in a semiconductor. State Flick's first law of	8				
5.25 × 50 / 12 / 20 / 20 / 20 / 20 / 20 / 20 / 2	20		diffusion in a semiconductor and derive the necessary equation.					
		(ii)	Describe in detail ion implantation process. Describe energy loss	8				
			mechanism of ions after entering into the semiconducting materials.					
	(b)	(\$&\$\B\\$\\$\\$\\$\\$\\$\\$\\$\\$\\$\\$\						
	2,750 70,00	(i)	Explain the various defects generated during the growth of epitaxial	4				
	770	7,00	layered thin films.					
		(ii)	Write a note on metalorganic chemical vapor deposition system.	4				
000		8 8 8 9 5 9 9						

3.	(a)	Attempt any one:				
		(i)	What do you understand by lithography? Draw a schematic diagram of X-	8		
			ray lithographic system and explain it in detail.	S S S		
		(ii)	Describe the etching process in semiconductor fabrication. Explain basic	8		
			mechanism of wet chemical etching and with neat labeled diagram,	300		
			describe wet chemical etching processes for silicon and silicon dioxide.			
	(b)	Attempt any one:				
		(i)	Write short note on dry etching process.	3 4		
		(ii)	Draw a schematic diagram of ion beam lithography system.	pt 4		
4.	(a)	Attempt any one:				
		(i)	Write note on (a) Integrated-circuit capacitor (b) Integrated circuit resistor.	8		
		(ii)	Write down various processes used for the fabrication of integrated circuit	8		
			(IC) using silicon planar technology. Discuss advantages of integrated			
			circuit over discrete component circuits.			
	(b)	Attempt any one:				
		(i)	Write note on simulation.	4		
		(ii)	Write note on bipolar technology.	4		
		É				
5.		Attempt any four:				
	(a) _) Draw a labeled diagram of chemical vapor deposition.		3		
Ê	(b)) Write note on reaction kinetics of SiO ₂ growth during film formation.		3		
	(c)	Write not on oxide masking in semiconductor growth process.		3		
100 P	(d)	Write note on optical lithography.		3		
	(e)	Write note on plasma etching.				
	(f)	Describe the necessity of clean room for IC fabrication.		3		
	(g)	Give	e the full form of (a) MOSFET (b) MESFET (c) MISFET (d) MOS (e)	3		
		CM	OS (f) ULSI,			
	(h)	Writ	te note on fundamental limits of integrated devices.	3		
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